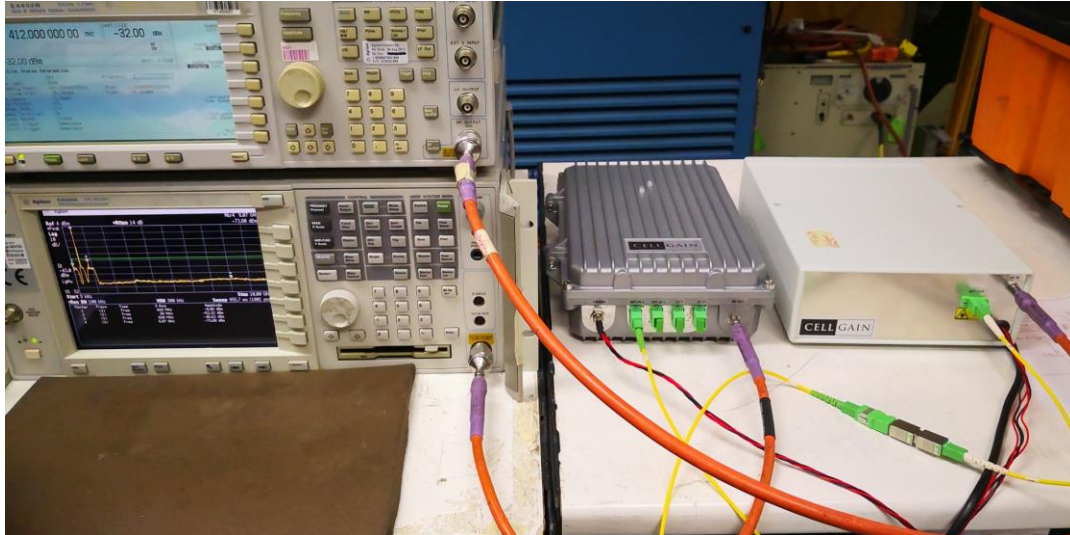
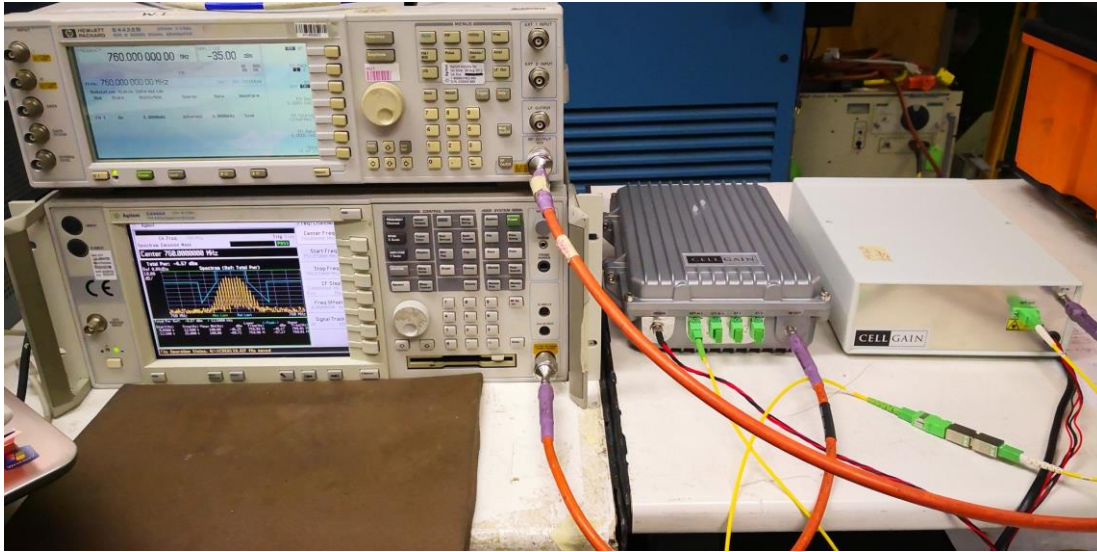


Section 14. Setup Photos

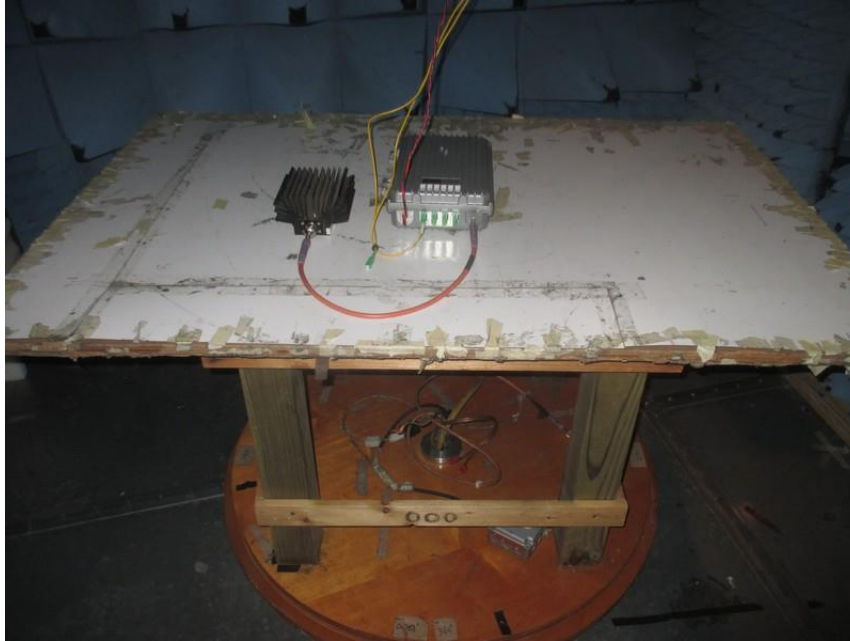
Conducted Measurement (OC, Spurious)



Emission Limitation Mask



Field Strength of Spurious



Frequency Stability

